

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

Hideki Fukano

Date: February 3, 2003

Serial No.: 10/005,705

Group Art Unit: 2815

Filed: December 4, 2001

Examiner: J. Jackson, Jr.

For:

SEMICONDUCTOR PHOTO-DETECTOR, SEMICONDUCTOR

PHOTODETECTION DEVICE, AND PRODUCTION METHODS THEREOF

Assistant Commissioner for Patents

Washington, D.C. 20231

AMENDMENT/SUBMISSION

Sir:

This is a response to the Office Action mailed November 1, 2002 in the above-identified application. Reconsideration of the application is respectfully requested.

FEE CALCULATION

Any additional fee required has been calculated as follows: If checked, "Small Entity" status is claimed.

| NO. CLAIN AFTER AMENDME | PR | HIGHEST NO. PREVIOUSLY PAID FOR | | EXTRA PRESENT | | | RAT | A | ADDIT. FEE | |
|--|---------------|---------------------------------------|---------|---------------|------|-------|-------------|-----------|---------------|--------|
| TOTAL 16 | MINUS | 20 | * = | | 0 | X | (\$9 SE o | r \$18) | \$ | |
| INDEP. 6 | MINUS | 6 | **= | | 0 | X | (\$42 SE c | or \$84) | \$ | |
| FIRST PRESENTAT | ION OF MULT | TIPLE DEPE | ENDEN | T CLAIM | | X | (\$140 SE c | or \$280) | \$ | |
| * not less than 20 ** not less than 3 TOTAL \$ | | | | | | | | | _ \$ -(|)_ |
| If any addi (OFGS Check No | itional payme | ent is requi attached. | ired, a | check wh | nich | inclu | des the cal | culated f | CENTER | 3 2003 |
| 00600100.1 | | | | 1 | | | | - | 2600 | |

^{*} not less than 20 ** not less than 3